

<b>Notice of References Cited</b>	Application/Control No. 09/660,186	Applicant(s)/Patent Under Reexamination KWAK, DONG YEUNG	
	Examiner Steven Loke	Art Unit 2811	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6016174	01-2000	Endo et al.	257/59
	B	US-			
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	E	US-			
	F	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N	JP-7-66419	03-1995	Japan	Matsuo et al.	257/59
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**NON-PATENT DOCUMENTS**

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